Bottom

4 G2

3 S2



ON Semiconductor®

FDWS9420-F085

N-Channel PowerTrench® MOSFET

40 V, 20 A, 5.8 mΩ

Features ■ Typical $R_{DS(on)}$ = 5.0 m Ω at V_{GS} = 10V, I_D = 20 A ■ Typical $Q_{q(tot)} = 29 \text{ nC}$ at $V_{GS} = 10 \text{ V}$, $I_D = 20 \text{ A}$ ■ UIS Capability ■ RoHS Compliant ■ Qualified to AEC Q101 Power 56 Dual ■ Wettable flanks for automatic optical inspection (AOI) **Applications** ■ Automotive Engine Control 7 PowerTrain Management

■ Integrated Starter/Alternator

Solenoid and Motor Drivers Electronic Steering

- Distributed Power Architectures and VRM
- Primary Switch for 12V Systems

MOSFET Maximum Ratings T_J = 25°C unless otherwise noted.

Symbol	Parameter	Ratings	Units	
V_{DSS}	Drain-to-Source Voltage		40	V
V_{GS}	Gate-to-Source Voltage	-	±20	V
ı	Drain Current - Continuous (V _{GS} =10) (Note 1) T _C = 25°C		20	Α
ID	Pulsed Drain Current	T _C = 25°C	See Figure 4	_ ^
E _{AS}	Single Pulse Avalanche Energy	(Note 2)	98	mJ
D	Power Dissipation		75	W
P_{D}	Derate Above 25°C		0.5	W/°C
T_J, T_{STG}	Operating and Storage Temperature		-55 to + 175	°C
$R_{\theta JC}$	Thermal Resistance, Junction to Case		2	°C/W
$R_{\theta JA}$	Maximum Thermal Resistance, Junction to Ambient	(Note 3)	50	°C/W

- 1: Current is limited by bondwire configuration.
- Starting T_J = 25°C, L = 1mH, I_{AS} = 14A, V_{DD} = 40V during inductor charging and V_{DD} = 0V during time in avalanche.
 R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta,JC}$ is guaranteed by design, while $R_{\theta,JA}$ is determined by the board design. The maximum rating presented here is based on mounting on a 1 in² pad of 2oz copper.

Package Marking and Ordering Information

Device Marking Device		Package	Package Reel Size		Quantity	
FDWS9420	FDWS9420-F085	Power56	13"	12mm	3000units	

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Publication Order Number: FDWS9420-F085/D

Units

Max.

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted.

Parameter

Off Characteristics							
B _{VDSS}	Drain-to-Source Breakdown Voltage	$I_D = 250 \mu A$	40	-	-	V	
ı	Drain-to-Source Leakage Current	V _{DS} =40V,	$T_{\rm J} = 25^{\rm o}{\rm C}$	-	-	1	μА
IDSS		$V_{GS} = 0V$	$T_J = 175^{\circ}C \text{ (Note 4)}$	-	-	1	mA
I _{GSS}	Gate-to-Source Leakage Current	$V_{GS} = \pm 20V$		-	-	±100	nA

Test Conditions

Min.

Тур.

On Characteristics

Symbol

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{I}$	_D = 250μA	2.0	3.0	4.0	V
R _{DS(on)} Drain to Source On Resistance	Drain to Course On Desistance	I _D = 20A,	$T_{J} = 25^{\circ}C$		5.0	5.8	mΩ
	V _{GS} = 10V	$T_J = 175^{\circ}C \text{ (Note 4)}$		8.5	10.0	mΩ	

Dynamic Characteristics

C _{iss}	Input Capacitance	V = 20V V = 0V	4-17	2100	-	pF
Coss	Output Capacitance	$V_{DS} = 20V, V_{GS} = 0V,$ f = 1MHz	A - C	710	-	pF
C _{rss}	Reverse Transfer Capacitance	111112	-	44	-	pF
R_g	Gate Resistance	f = 1MHz	-	1.8	-	Ω
$Q_{g(ToT)}$	Total Gate Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DD} = 20V$	-	29	43	nC
Q _{g(th)}	Threshold Gate Charge	$V_{GS} = 0 \text{ to } 2V$ $I_D = 20A$	-	3.9		nC
Q_{gs}	Gate-to-Source Gate Charge		-	9.5	1	nC
Q_{gd}	Gate-to-Drain "Miller" Charge		-	5.4	7-34	nC

Switching Characteristics

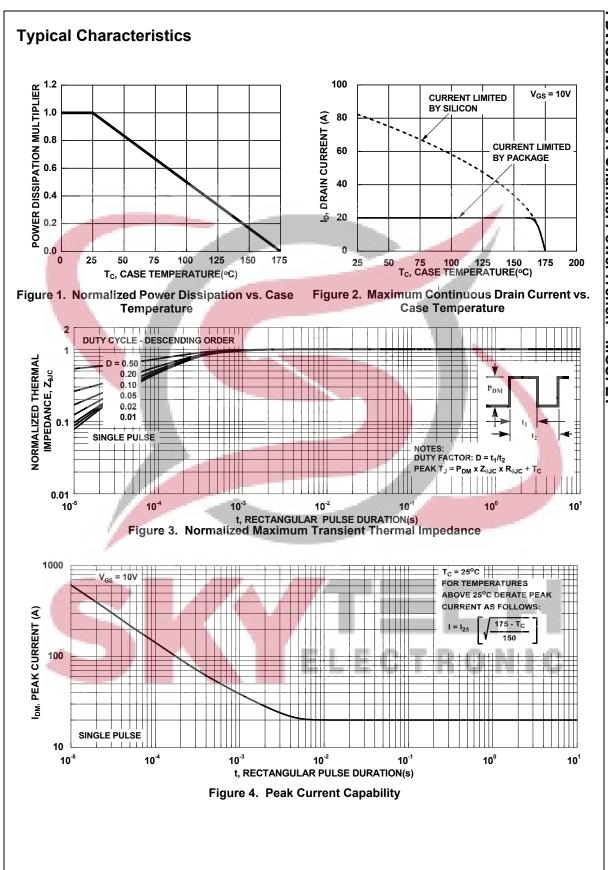
t _{on}	Turn-On Time			-	29	ns
t _{d(on)}	Turn-On Delay		7-	14	- 1	ns
t _r	Rise Time	$V_{DD} = 20V, I_{D} = 20A,$ $V_{GS} = 10V, R_{GEN} = 6\Omega$	-	8	-	ns
t _{d(off)}	Turn-Off Delay	V_{GS} = 10V, R_{GEN} = 6Ω	-	21		ns
t _f	Fall Time	4	-	6		ns
t _{off}	Turn-Off Time		-	-	35	ns

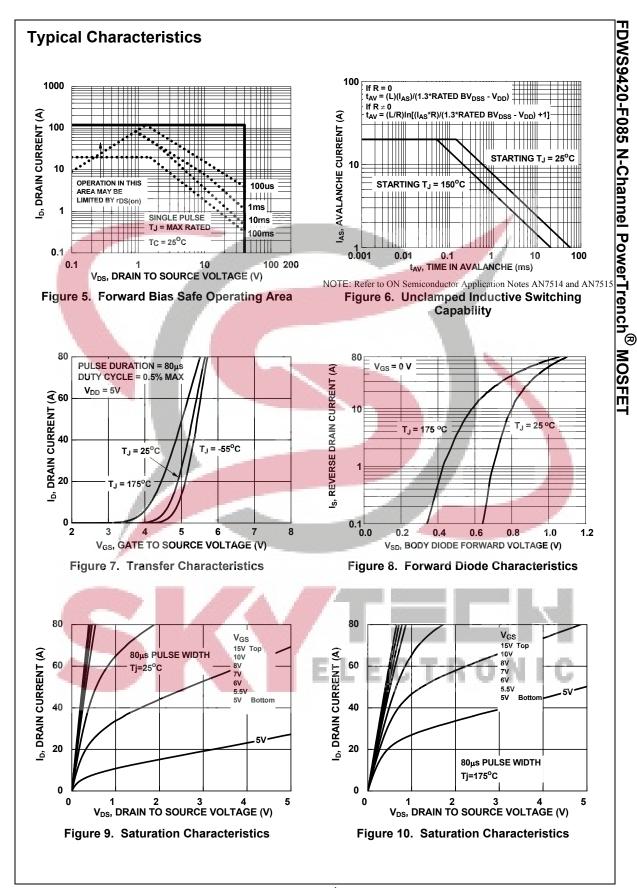
Drain-Source Diode Characteristics

V	Source to Drain Diade Voltage	4	I _{SD} =20A, V _{GS} = 0V		"	1.25	V	
V_{SD}	Source-to-Drain Diode Voltage		I _{SD} = 10A, V _{GS} = 0V	-		1.2	V	
t _{rr}	1	Reverse-Recovery Time	T	$I_F = 20A$, $dI_{SD}/dt = 100A/\mu s$		48	63	ns
Q _{rr}		Reverse-Recovery Charge	T	V _{DD} = 32V	-	40	52	nC

Note:

4: The maximum value is specified by design at T_J = 175°C. Product is not tested to this condition in production.







Typical Characteristics

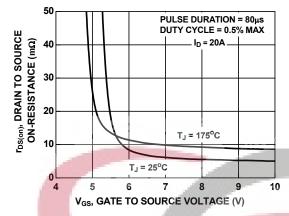


Figure 11. R_{DSON} vs. Gate Voltage

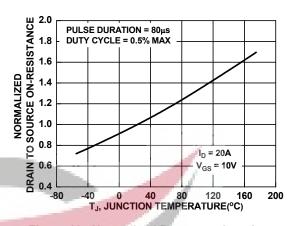


Figure 12. Normalized R_{DSON} vs. Junction Temperature

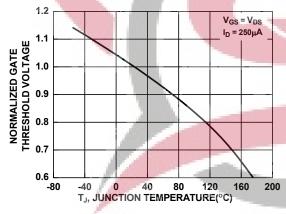


Figure 13. Normalized Gate Threshold Voltage vs. Temperature

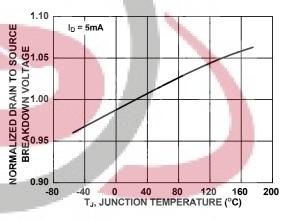


Figure 14. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

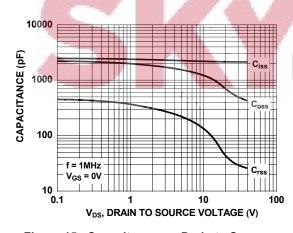


Figure 15. Capacitance vs. Drain to Source Voltage

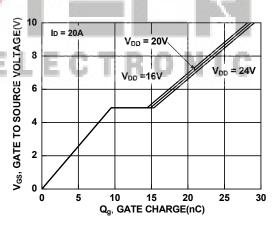
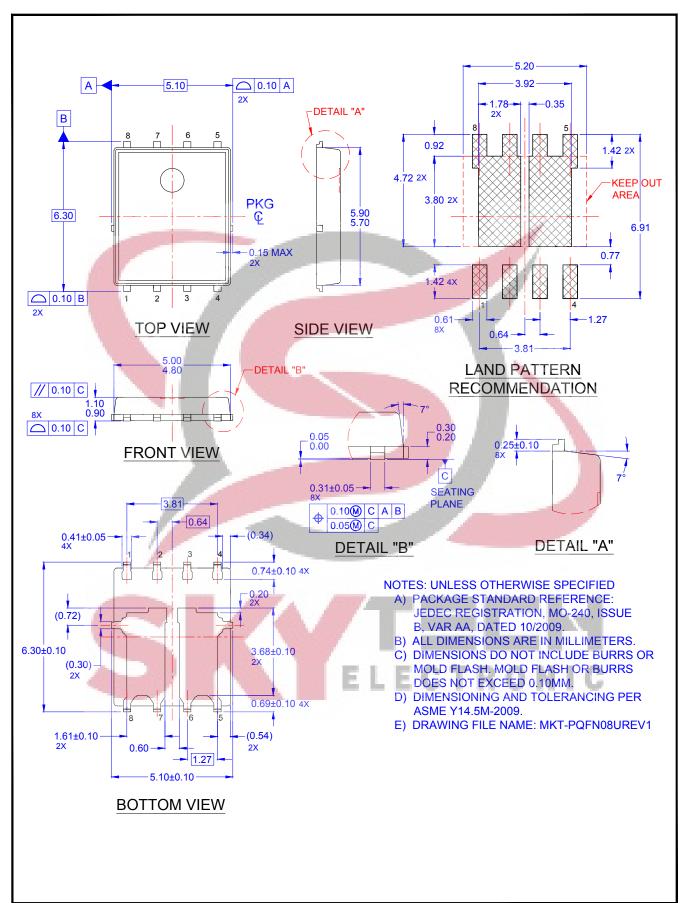


Figure 16. Gate Charge vs. Gate to Source Voltage





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